ISO/TC61/SC11/WG3 – Pre NWIP

Plastic films for organic electric devices - Determination of water vapour transmission rate -Instrumental method

Japan Barrier Society

✓ Background

- Features and market trend of flexible electronics devices
- High-barrier film as substrate of flexible electronics devices
- Conventional ISO standard of barrier testing method
- ✓ Testing method of high-barrier film
- Advantage of ISO standardization for high-barrier testing methods

✓ Summary

Flexible electronics devices



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Features of flexible electronics devices

✓ Low-price

- High productivity by Roll-to-Roll process
- Low shipping cost due to light weight
- 100 \$ PC and electrical coursebooks for children

✓ Portability

- Rollable or bendable device
- Without electric facilities,
 operation of portable PC, TV, and lighting
 by portable PV



Electrical devices for everyone, in everywhere

✓ Renewable Energy

Low cost and light weight solar cell







✓ Education

Low cost electrical coursebook for every children

\checkmark Low CO₂ emission

Light and thin products save transport cost and energy



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Global market forecast for organic devices

Global market sales (\$ million) of organic devices in 2010-2020E - Organic devices: OLED display, OLED lighting, E-paper, and organic solar cell -



Full-fledged market expansion of flexible display is predicted after 2015
 In 2020, half of all organic devices are going to be flexible devices

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"Glass" to "Plastic"

Required properties for substrate of electronics device

| | Glass | Plastic |
|-----------------------|-------|---------|
| Flexibility | | +++ |
| Impact resistance | - | ++ |
| Water-vapour barrier | + | |
| Heat-resistance | + | |
| Dimensional stability | ++ | |
| Light weight | - | + + |
| Production cost | - | + + |
| Thinness | - | + |

Plastic substrate requires water-vapour barrier property

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Why does OLED require high-barrier substrate?



Shortage of life time for luminance of OLED

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High-barrier film



ex) AlOx, SiOx ...

Requirement of barrier properties



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Conventional ISO standards

✓ ISO-02528

Cup method

✓ ISO-15106-1

Humidity detection sensor method

✓ ISO-15106-2

Infrared detection sensor method

✓ ISO-15106-3

Electrolytic detection sensor method

✓ ISO-15106-4

Gas-chromatographic detection sensor method

Current methods for high-barrier measurement



Ex.1: High sensitive pressure gauge method

WVTR can be calculated by water vapour pressure through barrier film

- Differential pressure method
- Slope of P(t) is proportional to WVTR
- Calibration by standard sample is unnecessary





H. Norenberg

Proc. of the International Display Workshop 2008, p.1435 (2008)

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WVTR can be calculated by reacted Ca metal amount







G. Nisato et al. *Proc. of the International Display Workshop/Asia Display, 2001,* 1435 (2001)

Ex.3: Atmospheric Pressure Ionization Mass Spectrometry

WVTR can be calculated by water vapour pressure through barrier film

- Equal-pressure method
- High sensitive detector API-MS
 API-MS sensitivity can detect
 0.0015ppb of H₂O in N₂ gas



Specification brochure in NIHON API

<u>www.apinet.co.jp</u>

Advantage of standardization for WVTR testing



✓ Customer : Re-evaluation is unnecessary

✓ Supplier : Original method/condition development is unnecessary

Summary

- ✓ Flexible electronics device markets begin to grow up by 2015
- ✓ High-barrier films are key material for flexible electronics devices
- ✓ ISO-15106 series do NOT cover WVTR of high-barrier films
- ✓ Various testing methods for high-barrier films have been proposed



ISO standardization for the high-barrier testing method is required !!

References

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9) T.Clausen et al., DOE Solid State Lighting Manufacturing Workshop (2009)

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